

# BEST AVAILABLE COPY

<b>Notice of References Cited</b>	Application/Control No. 09/917,224	Applicant(s)/Patent Under Reexamination KLEIN ET AL.	
	Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,217,272	04-2001	Felsenthal et al.	414/217
	B	US-5,269,643	12-1993	Kodama et al.	414/416.02
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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